

ASYMMETRIC DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Features

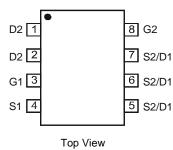
- DIOFET utilize a unique patented process to monolithically integrate a MOSFET and a Schottky in a single die to deliver:
 - Low R_{DS(on)} minimizes conduction loss
 - Low V_{SD} reducing the losses due to body diode construction
 - Low Q_{rr} lower Q_{rr} of the integrated Schottky reduces body diode switching losses
 - Low gate capacitance (Q_g/Q_{gs}) ratio reduces risk of shootthrough or cross conduction currents at high frequencies
 - Avalanche rugged $I_{\mbox{\scriptsize AR}}$ and $E_{\mbox{\scriptsize AR}}$ rated
- Lead Free By Design/RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

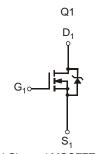
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Weight: 0.072 grams (approximate)

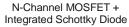


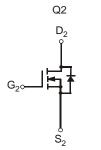




Internal Schematic







N-Channel MOSFET

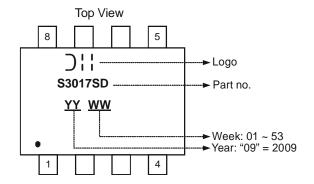
Ordering Information (Note 3)

Part Number	Case	Packaging
DMS3017SSD-13	SO-8	2500 / Tape & Reel

Notes:

- 1. No purposefully added lead.
- 2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com/products/lead_free/index.php.
- 3. For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

Marking Information





Maximum Ratings - Q1 @TA = 25°C unless otherwise specified

Characte	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	30	V		
Gate-Source Voltage	V_{GSS}	±20	V		
Continuous Drain Current (Note 4) V _{GS} = 10V	Steady State	T _A = 25°C T _A = 70°C	I _D	8.0 6.5	А
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	T _A = 25°C T _A = 70°C	I _D	10 7.8	А
Continuous Drain Current (Note 5) V _{GS} = 4.5V	Steady State	T _A = 25°C T _A = 70°C	I _D	8.7 7.0	А
Pulsed Drain Current (Note 6)	I _{DM}	60	Α		
Avalanche Current (Notes 6 & 7)	I _{AR}	16	А		
Repetitive Avalanche Energy (Notes 6 & 7) L = 0	E _{AR}	12.8	mJ		

Maximum Ratings - Q2 @TA = 25°C unless otherwise specified

Character	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	30	V		
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Drain Current (Note 4) V _{GS} = 10V	Steady State	T _A = 25°C T _A = 70°C	I _D	6.0 4.7	А
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	T _A = 25°C T _A = 70°C	I _D	7.2 6.0	А
Continuous Drain Current (Note 5) V _{GS} = 4.5V	Steady State	T _A = 25°C T _A = 70°C	I _D	6.0 5.0	А
Pulsed Drain Current (Note 6)	I _{DM}	60	Α		
Avalanche Current (Notes 6 & 7)	I _{AR}	16	Α		
Repetitive Avalanche Energy (Notes 6 & 7) L = 0	E _{AR}	12.8	mJ		

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 4)	P _D	1.19	W
Thermal Resistance, Junction to Ambient @T _A = 25°C (Note 4)	$R_{\theta JA}$	107	°C/W
Power Dissipation (Note 5)	P _D	1.79	W
Thermal Resistance, Junction to Ambient @T _A = 25°C (Note 5)	R _{0JA}	70	°C/W
Operating and Storage Temperature Range	T_{J}, T_{STG}	-55 to +150	°C

Notes:

- 4. Device mounted on FR-4 substrate PC board, with minimum recommended pad layout. The value in any given application depends on the user's specific board design. Device contains two active die running at equal power.
- 5. Device mounted on 1 inch x 1 inch FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. Device contains two active die running at equal power.
- 6. Repetitive rating, pulse width limited by junction temperature.
- 7. I_{AR} and E_{AR} rating are based on low frequency and duty cycles to keep $T_J = 25^{\circ}C$

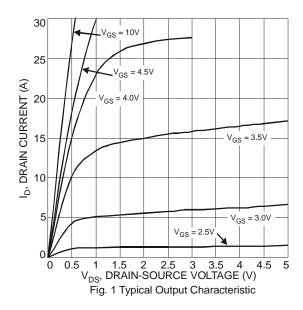


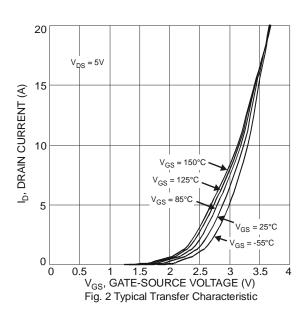
Electrical Characteristics – Q1 @ T_A = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	-	-	100	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.0	-	2.5	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	D		8.5	12	mΩ	$V_{GS} = 10V, I_D = 9.5A$
Static Dialii-Source Off-Resistance	R _{DS (ON)}	-	9.5	15	111 2 2	$V_{GS} = 4.5V, I_D = 8.8A$
Forward Transfer Admittance	Y _{fs}	1	18	-	S	$V_{DS} = 5V, I_{D} = 9.5A$
Diode Forward Voltage	V _{SD}	-	0.45	0.60	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	-	1276	-		V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	Coss	-	160	-	pF	
Reverse Transfer Capacitance	C _{rss}	-	136	-		
Gate Resistance	R_{g}	-	1.48	2.7	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	14.3	-		$V_{DS} = 15V, V_{GS} = 4.5V, I_{D} = 8.8A$
Total Gate Charge (V _{GS} = 10V)	Qg	-	30.6	-	nC	
Gate-Source Charge	Q _{gs}	-	3.4	-	nc	$V_{DS} = 15V, V_{GS} = 10V, I_{D} = 8.8A$
Gate-Drain Charge	Q_{gd}	-	4.3	-		VDS = 13V, VGS = 10V, ID = 8.6A
Turn-On Delay Time	t _{D(on)}	-	15.8	-		
Turn-On Rise Time	t _r	-	27.8	-		$V_{GS} = 4.5V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(off)}	-	29.7	-	ns	$R_G = 1.8\Omega, I_D = 8.8A$
Turn-Off Fall Time	t _f	-	13.6	-		

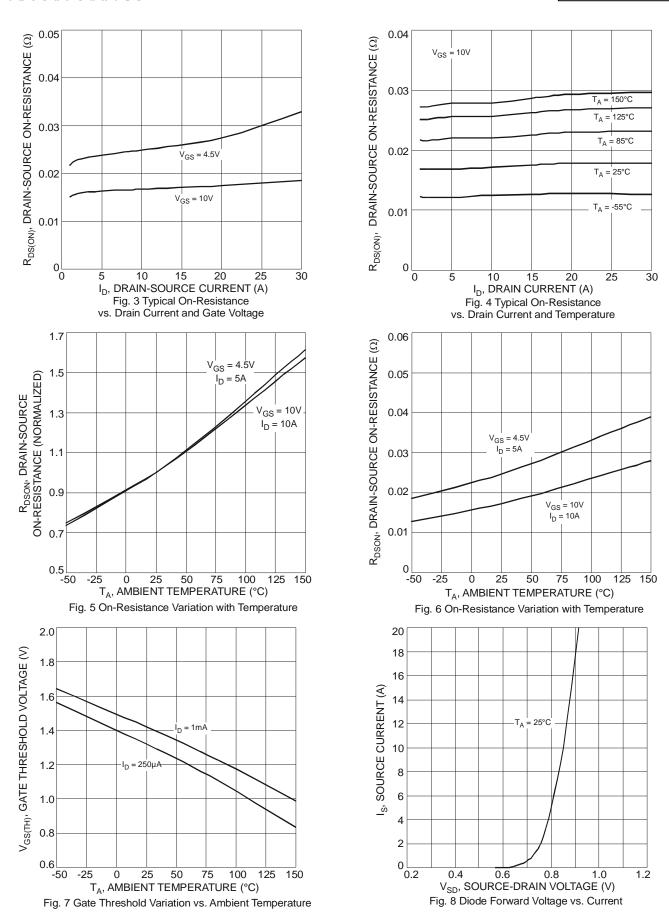
Notes:

- 8. Short duration pulse test used to minimize self-heating effect.
- 9. Guaranteed by design. Not subject to production testing.

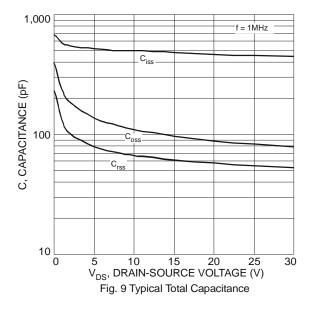


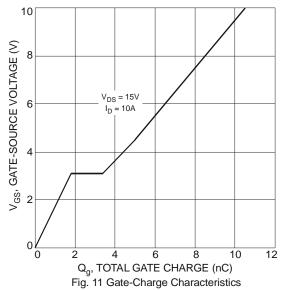


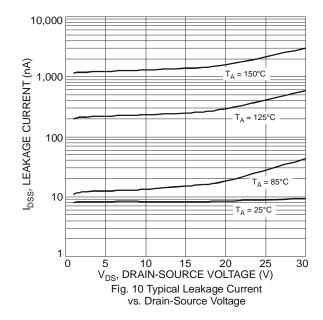












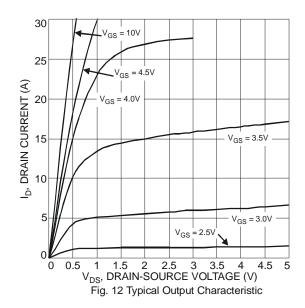


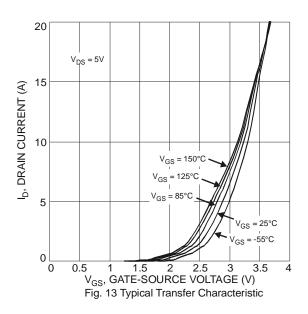
Electrical Characteristics – Q2 @ T_A = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V$, $I_D = 1mA$
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.0	-	2.4	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	D		15	22	mΩ	$V_{GS} = 10V, I_D = 8.8A$
Static Drain-Source On-Nesistance	R _{DS} (ON)	-	25	32	111 2 2	$V_{GS} = 4.5V, I_D = 7A$
Forward Transfer Admittance	Y _{fs}	-	2.5	-	S	$V_{DS} = 5V, I_{D} = 8.8A$
Diode Forward Voltage	V _{SD}	-	0.7	1	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	-	478.9	-		V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	Coss	-	96.7	-	pF	
Reverse Transfer Capacitance	C _{rss}	-	61.4	-		
Gate Resistance	Rg	-	1.1	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	5.0	-		V _{DS} = 15V, V _{GS} = 4.5V, I _D = 10A
Total Gate Charge (V _{GS} = 10V)	Qg	-	10.5	-	20	$V_{DS} = 15V, V_{GS} = 10V, I_D = 10A$
Gate-Source Charge	Q _{gs}	-	1.8	-	nC	
Gate-Drain Charge	Q_{gd}	-	1.6	-		
Turn-On Delay Time	t _{D(on)}	-	2.9	-		
Turn-On Rise Time	t _r	-	7.9	-		$V_{GS} = 10V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(off)}	-	14.6	-	ns	$R_G = 3\Omega$, $R_L = 1.5\Omega$
Turn-Off Fall Time	t _f	-	3.1	-		

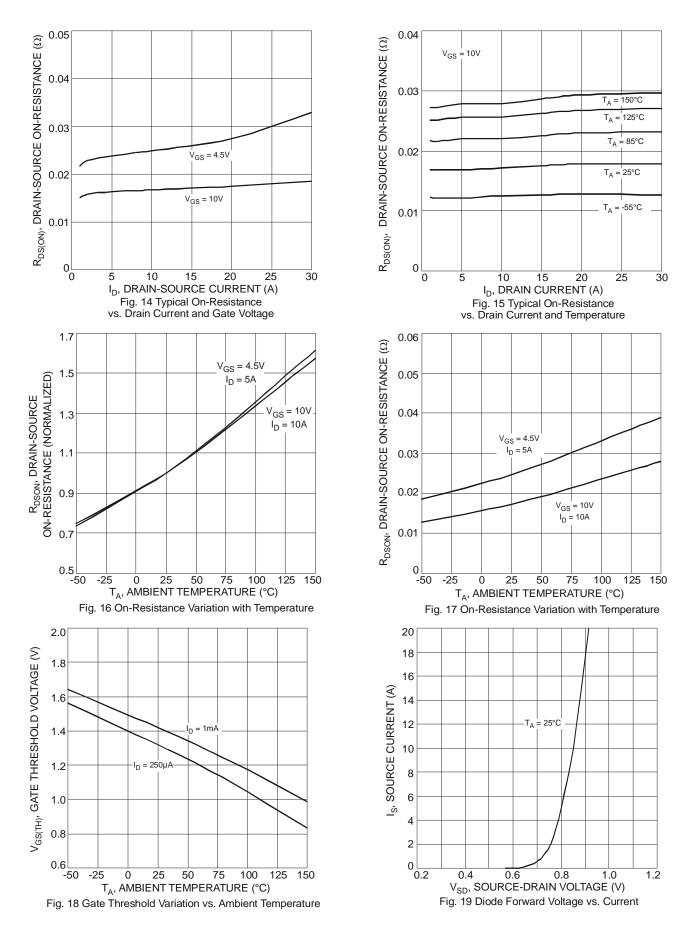
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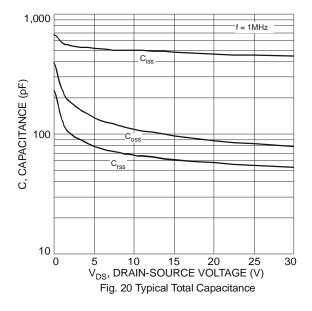


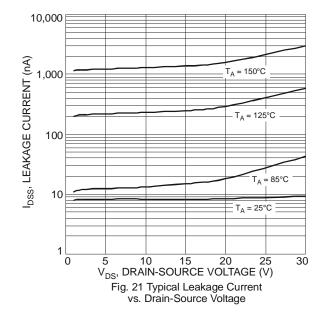


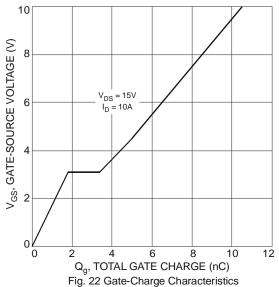


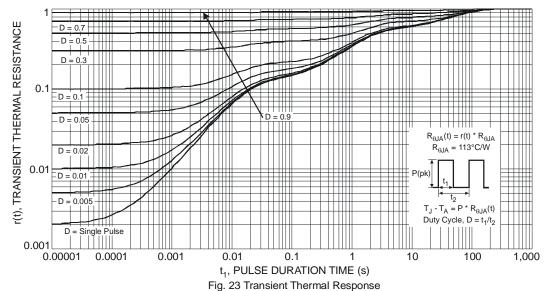






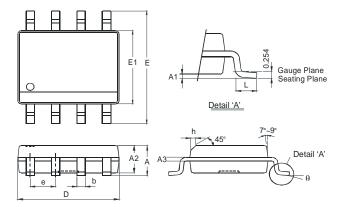






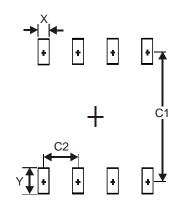


Package Outline Dimensions



SO-8					
Dim	Min	Max			
Α	-	1.75			
A 1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	1	0.35			
٦	0.62	0.82			
θ	0°	8°			
All Di	All Dimensions in mm				

Suggested Pad Layout



Dimensions	Value (in mm)
X	0.60
Y	1.55
C1	5.4
C2	1 27



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